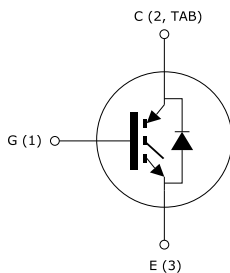
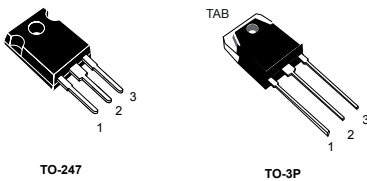


Trench gate field-stop 650 V, 80 A high speed HB series IGBT



Features

- Maximum junction temperature: $T_J = 175\text{ }^\circ\text{C}$
- High speed switching series
- Minimized tail current
- Low saturation voltage: $V_{CE(sat)} = 1.6\text{ V (typ.) @ } I_C = 80\text{ A}$
- Tight parameter distribution
- Safe paralleling
- Positive $V_{CE(sat)}$ temperature coefficient
- Low thermal resistance
- Very fast soft recovery antiparallel diode

Applications

- Photovoltaic inverters
- High frequency converters

Description

These devices are IGBTs developed using an advanced proprietary trench gate field-stop structure. These devices are part of the new HB series of IGBTs, which represent an optimum compromise between conduction and switching loss to maximize the efficiency of any frequency converter. Furthermore, the slightly positive $V_{CE(sat)}$ temperature coefficient and very tight parameter distribution result in safer paralleling operation.

Product status link

[STGW80H65DFB](#)
[STGWT80H65DFB](#)

Product summary

| | |
|------------|---------------|
| Order code | STGW80H65DFB |
| Marking | GW80H65DFB |
| Package | TO-247 |
| Packing | Tube |
| Order code | STGWT80H65DFB |
| Marking | GWT80H65DFB |
| Package | TO-3P |
| Packing | Tube |

1 Electrical ratings

Table 1. Absolute maximum ratings

| Symbol | Parameter | Value | Unit |
|-------------------------|--|--------------------|------|
| V_{CES} | Collector-emitter voltage ($V_{GE} = 0$) | 650 | V |
| I_C | Continuous collector current at $T_C = 25\text{ °C}$ | 120 ⁽¹⁾ | A |
| | Continuous collector current at $T_C = 100\text{ °C}$ | 80 | |
| I_{CP} ⁽²⁾ | Pulsed collector current ($t_p \leq 1\ \mu\text{s}$, $T_J < 175\text{ °C}$) | 300 | A |
| V_{GE} | Gate-emitter voltage | ± 20 | V |
| | Transient gate-emitter voltage | ± 30 | V |
| I_F | Continuous forward current at $T_C = 25\text{ °C}$ | 120 ⁽¹⁾ | A |
| | Continuous forward current at $T_C = 100\text{ °C}$ | 80 | |
| I_{FP} ⁽²⁾ | Pulsed forward current ($t_p \leq 1\ \mu\text{s}$, $T_J < 175\text{ °C}$) | 300 | A |
| P_{TOT} | Total power dissipation at $T_C = 25\text{ °C}$ | 470 | W |
| T_{STG} | Storage temperature range | - 55 to 150 | °C |
| T_J | Operating junction temperature range | - 55 to 175 | |

1. Current level is limited by bond wires
2. Defined by design, not subject to production test.

Table 2. Thermal data

| Symbol | Parameter | Value | Unit |
|------------|--|-------|------|
| R_{thJC} | Thermal resistance junction-case IGBT | 0.32 | °C/W |
| R_{thJC} | Thermal resistance junction-case diode | 0.66 | |
| R_{thJA} | Thermal resistance junction-ambient | 50 | |

2 Electrical characteristics

$T_C = 25\text{ °C}$ unless otherwise specified

Table 3. Static characteristics

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|---------------|--------------------------------------|--|------|------|-----------|---------------|
| $V_{(BR)CES}$ | Collector-emitter breakdown voltage | $V_{GE} = 0\text{ V}, I_C = 2\text{ mA}$ | 650 | | | V |
| $V_{CE(sat)}$ | Collector-emitter saturation voltage | $V_{GE} = 15\text{ V}, I_C = 80\text{ A}$ | | 1.6 | 2 | V |
| | | $V_{GE} = 15\text{ V}, I_C = 80\text{ A}, T_J = 125\text{ °C}$ | | 1.8 | | |
| | | $V_{GE} = 15\text{ V}, I_C = 80\text{ A}, T_J = 175\text{ °C}$ | | 1.9 | | |
| V_F | Forward on-voltage | $I_F = 80\text{ A}$ | | 1.9 | 2.3 | V |
| | | $I_F = 80\text{ A}, T_J = 125\text{ °C}$ | | 1.6 | | |
| | | $I_F = 80\text{ A}, T_J = 175\text{ °C}$ | | 1.5 | | |
| $V_{GE(th)}$ | Gate threshold voltage | $V_{CE} = V_{GE}, I_C = 1\text{ mA}$ | 5 | 6 | 7 | V |
| I_{CES} | Collector cut-off current | $V_{GE} = 0\text{ V}, V_{CE} = 650\text{ V}$ | | | 100 | μA |
| I_{GES} | Gate-emitter leakage current | $V_{CE} = 0\text{ V}, V_{GE} = \pm 20\text{ V}$ | | | ± 250 | nA |

Table 4. Dynamic characteristics

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------|------------------------------|---|------|-------|------|---------------|
| C_{ies} | Input capacitance | $V_{CE} = 25\text{ V}, f = 1\text{ MHz}, V_{GE} = 0\text{ V}$ | - | 10524 | - | μF |
| C_{oes} | Output capacitance | | - | 385 | - | |
| C_{res} | Reverse transfer capacitance | | - | 215 | - | |
| Q_g | Total gate charge | $V_{CC} = 520\text{ V}, I_C = 80\text{ A}, V_{GE} = 15\text{ V}$ (see Figure 29. Gate charge test circuit) | - | 414 | - | nC |
| Q_{ge} | Gate-emitter charge | | - | 78 | - | |
| Q_{gc} | Gate-collector charge | | - | 170 | - | |

Table 5. IGBT switching characteristics (inductive load)

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------------|---------------------------|--|------|------|------|------------------|
| $t_{d(on)}$ | Turn-on delay time | $V_{CE} = 400\text{ V}$, $I_C = 80\text{ A}$, $V_{GE} = 15\text{ V}$, $R_G = 10\ \Omega$ (see Figure 28. Test circuit for inductive load switching) | | 84 | - | ns |
| t_r | Current rise time | | | 52 | - | |
| $(di/dt)_{on}$ | Turn-on current slope | | | 1270 | - | A/ μs |
| $t_{d(off)}$ | Turn-off-delay time | | | 280 | - | ns |
| t_f | Current fall time | | | 31 | - | |
| $E_{on}^{(1)}$ | Turn-on switching energy | | | 2.1 | - | mJ |
| $E_{off}^{(2)}$ | Turn-off switching energy | | | 1.5 | - | |
| E_{ts} | Total switching energy | | 3.6 | - | | |
| $t_{d(on)}$ | Turn-on delay time | $V_{CE} = 400\text{ V}$, $I_C = 80\text{ A}$, $V_{GE} = 15\text{ V}$, $R_G = 10\ \Omega$, $T_J = 175\text{ }^\circ\text{C}$ (see Figure 28. Test circuit for inductive load switching) | | 77 | - | ns |
| t_r | Current rise time | | | 51 | - | |
| $(di/dt)_{on}$ | Turn-on current slope | | | 1270 | - | A/ μs |
| $t_{d(off)}$ | Turn-off-delay time | | | 328 | - | ns |
| t_f | Current fall time | | | 30 | - | |
| $E_{on}^{(1)}$ | Turn-on switching energy | | | 4.4 | - | mJ |
| $E_{off}^{(2)}$ | Turn-off switching energy | | | 2.1 | - | |
| E_{ts} | Total switching energy | | 6.5 | - | | |

1. Including the reverse recovery of the diode.
2. Including the tail of the collector current.

Table 6. Diode switching characteristics (inductive load)

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit | |
|--------------|--|---|------|------|------|------|------------------|
| t_{rr} | Reverse recovery time | $I_F = 80\text{ A}$, $V_R = 400\text{ V}$, $V_{GE} = 15\text{ V}$ di/ $dt = 100\text{ A}/\mu\text{s}$ (see Figure 28. Test circuit for inductive load switching) | - | 85 | - | ns | |
| Q_{rr} | Reverse recovery charge | | | - | 1105 | - | nC |
| I_{rrm} | Reverse recovery current | | | - | 26 | - | A |
| di_{rr}/dt | Peak rate of fall of reverse recovery current during t_b | | | - | 722 | - | A/ μs |
| E_{rr} | Reverse recovery energy | | | - | 267 | - | μJ |
| t_{rr} | Reverse recovery time | $I_F = 80\text{ A}$, $V_R = 400\text{ V}$, $V_{GE} = 15\text{ V}$, $T_J = 175\text{ }^\circ\text{C}$ di/dt = $100\text{ A}/\mu\text{s}$ (see Figure 28. Test circuit for inductive load switching) | - | 149 | - | ns | |
| Q_{rr} | Reverse recovery charge | | | - | 4920 | - | nC |
| I_{rrm} | Reverse recovery current | | | - | 66 | - | A |
| di_{rr}/dt | Peak rate of fall of reverse recovery current during t_b | | | - | 546 | - | A/ μs |
| E_{rr} | Reverse recovery energy | | | - | 1172 | - | μJ |

2.1 Electrical characteristics (curves)

Figure 1. Power dissipation vs case temperature

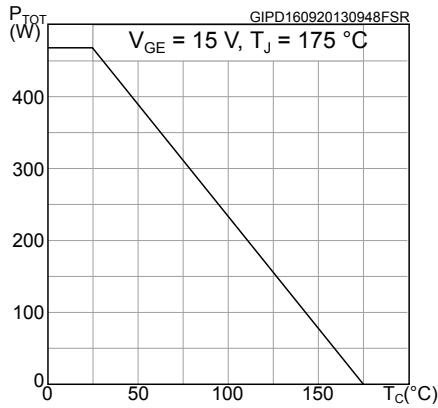


Figure 2. Collector current vs case temperature

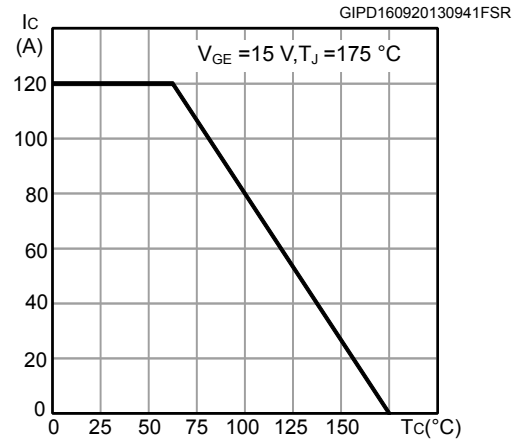


Figure 3. Output characteristics ($T_J = 25\text{ °C}$)

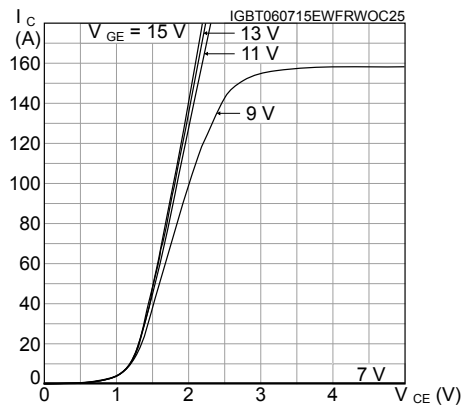


Figure 4. Output characteristics ($T_J = 175\text{ °C}$)

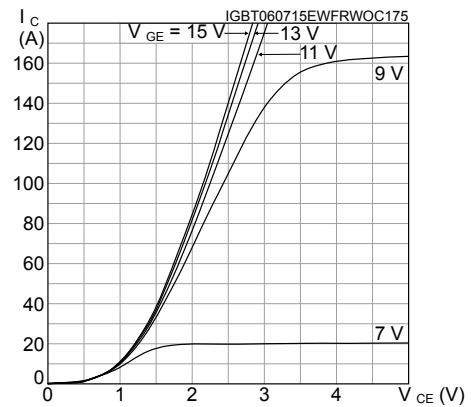


Figure 5. $V_{CE(sat)}$ vs junction temperature

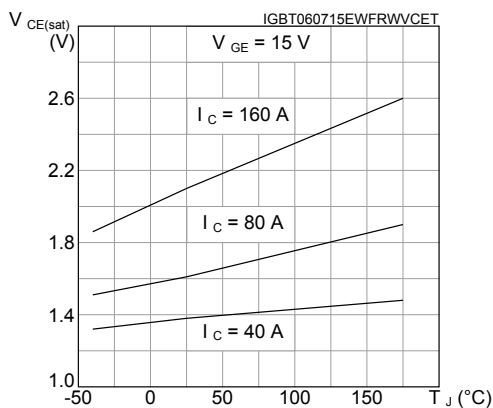


Figure 6. $V_{CE(sat)}$ vs collector current

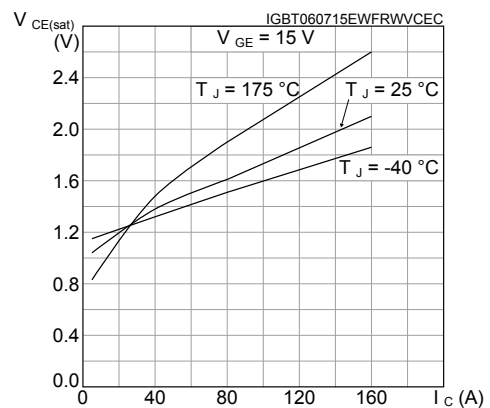


Figure 7. Collector current vs switching frequency

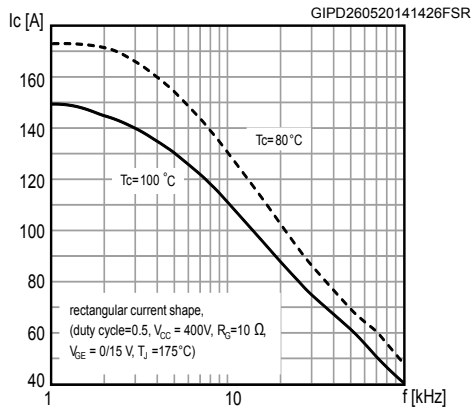


Figure 8. Forward bias safe operating area

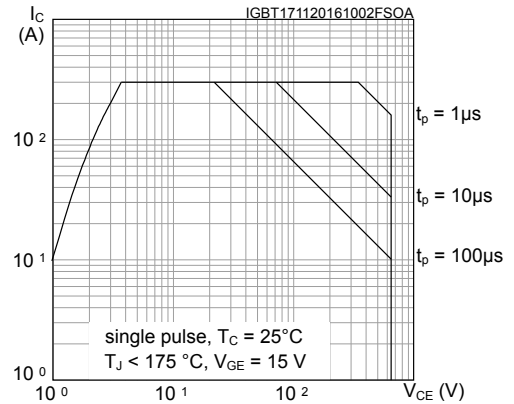


Figure 9. Transfer characteristics

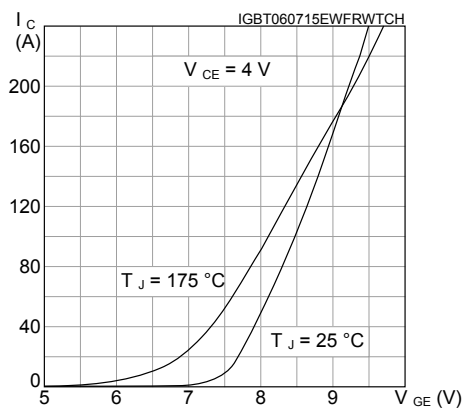


Figure 10. Diode Vf vs forward current

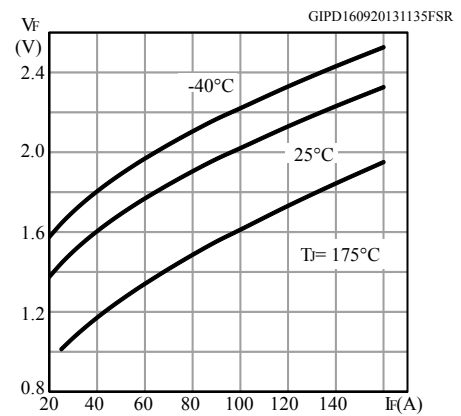


Figure 11. Normalized VGE(th) vs junction temperature

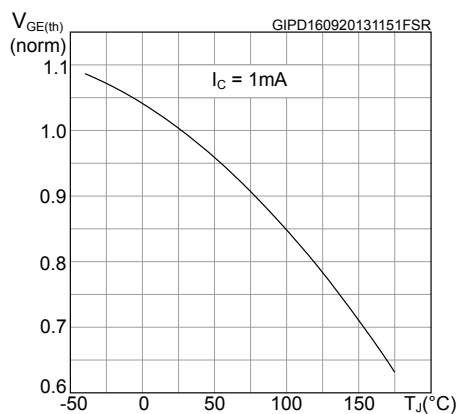


Figure 12. Normalized VBR(CES) vs junction temperature

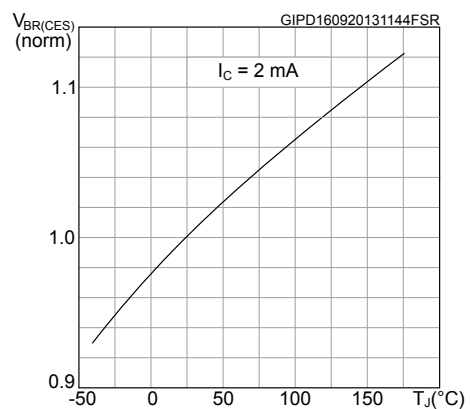


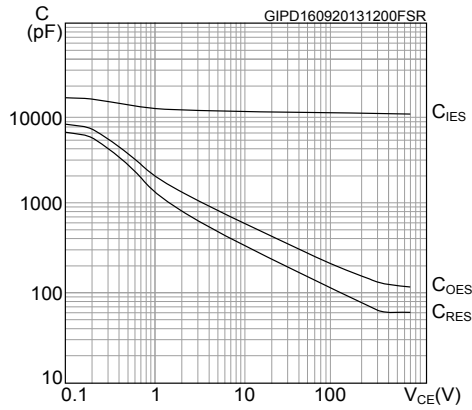
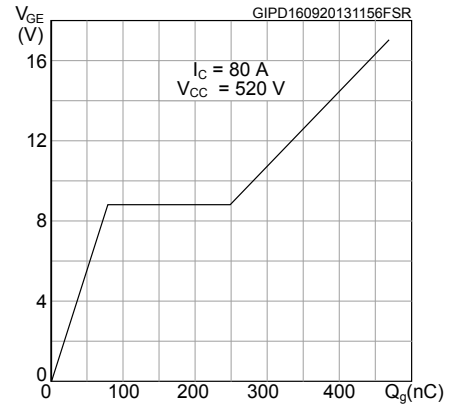
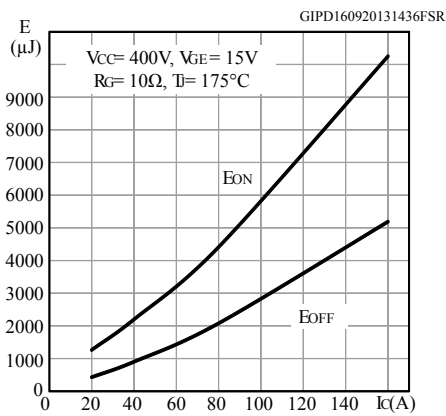
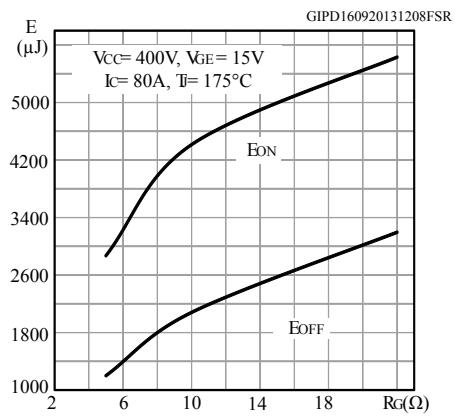
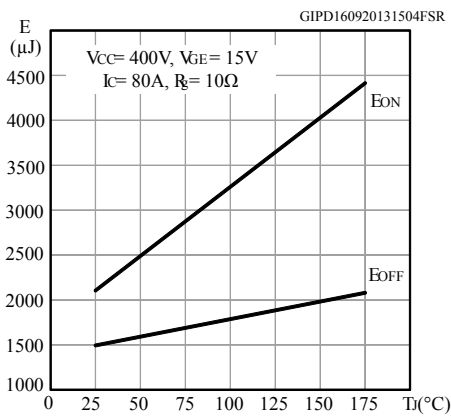
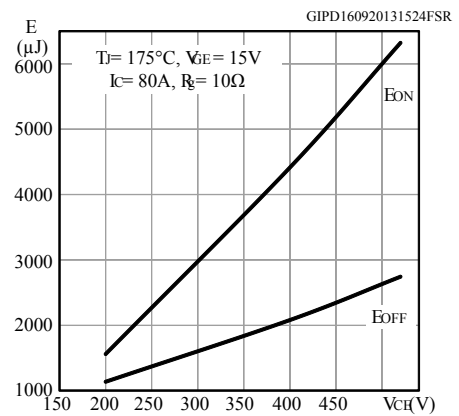
Figure 13. Capacitance variations

Figure 14. Gate charge vs gate-emitter voltage

Figure 15. Switching energy vs collector current

Figure 16. Switching energy vs gate resistance

Figure 17. Switching energy vs temperature

Figure 18. Switching energy vs collector emitter voltage


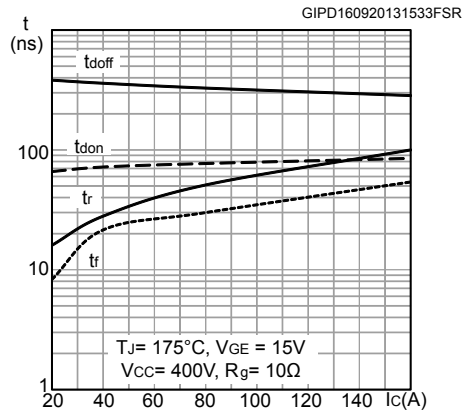
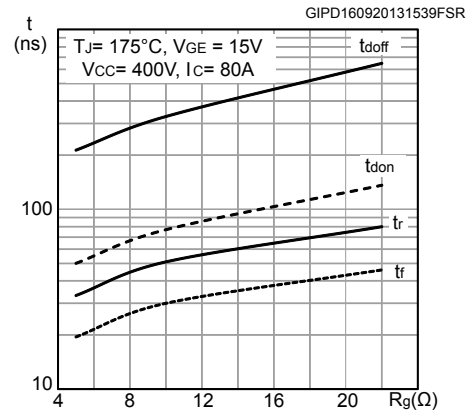
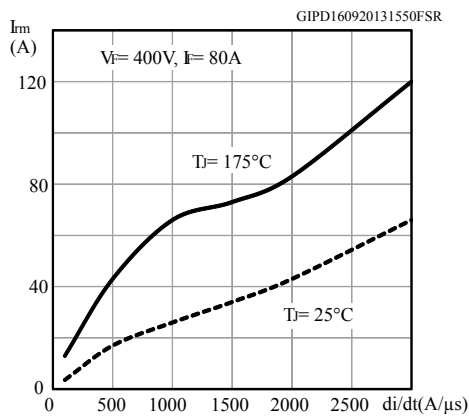
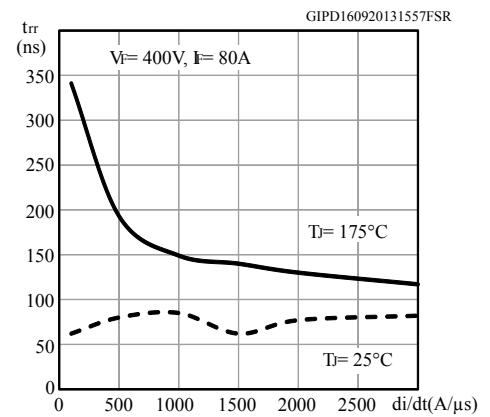
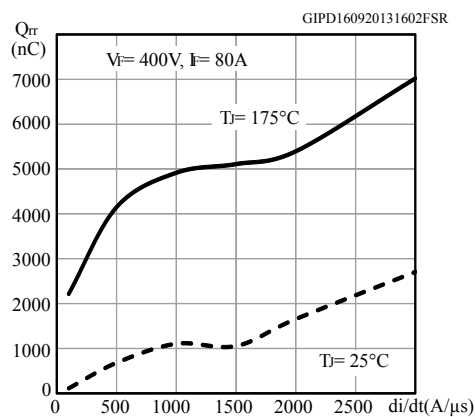
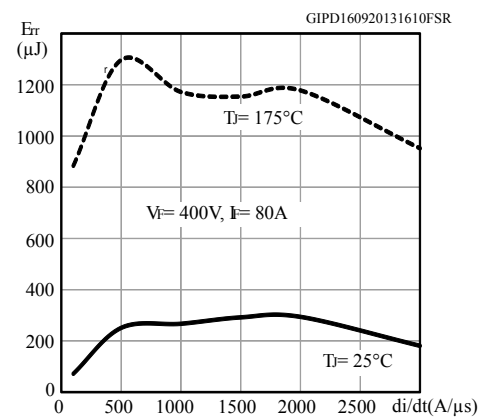
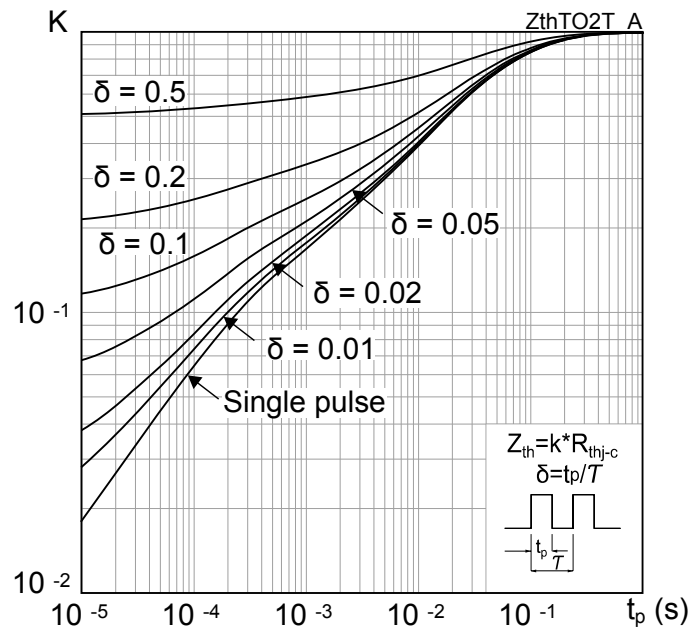
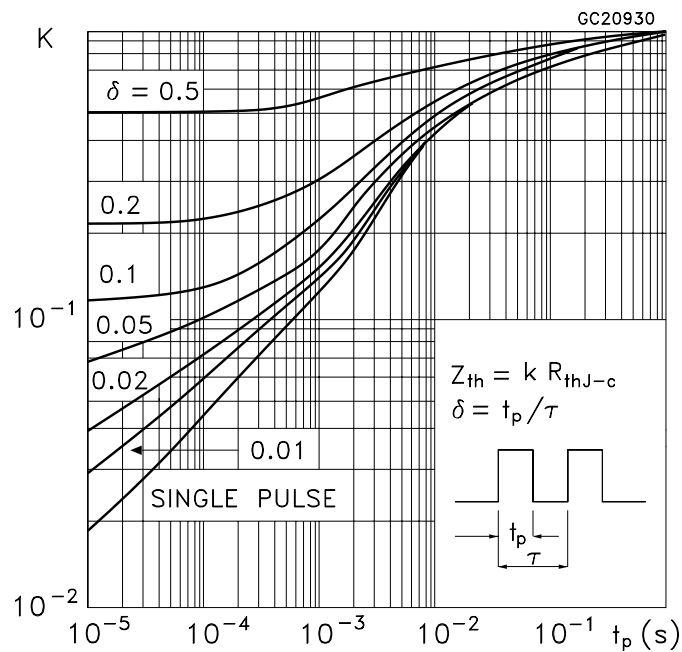
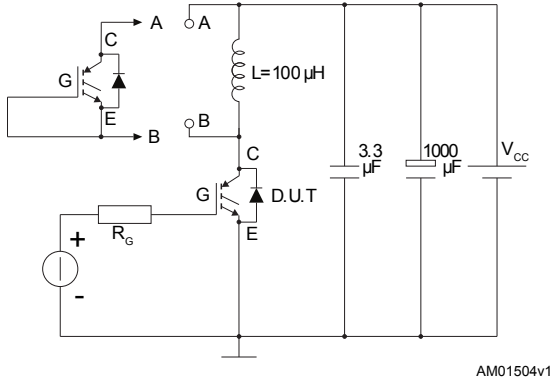
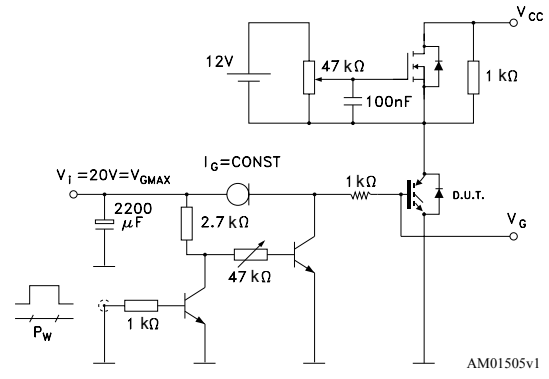
Figure 19. Switching times vs collector current

Figure 20. Switching times vs gate resistance

Figure 21. Reverse recovery current vs diode current slope

Figure 22. Reverse recovery time vs diode current slope

Figure 23. Reverse recovery charge vs diode current slope

Figure 24. Reverse recovery energy vs diode current slope


Figure 25. Thermal impedance for IGBT

Figure 26. Thermal impedance for diode


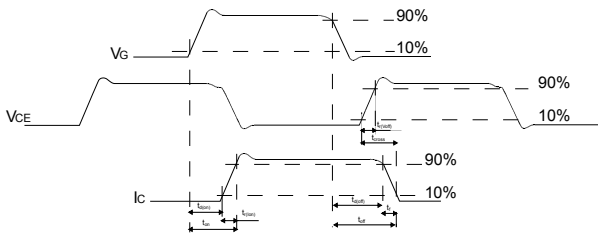
3 Test circuits

Figure 27. Test circuit for inductive load switching

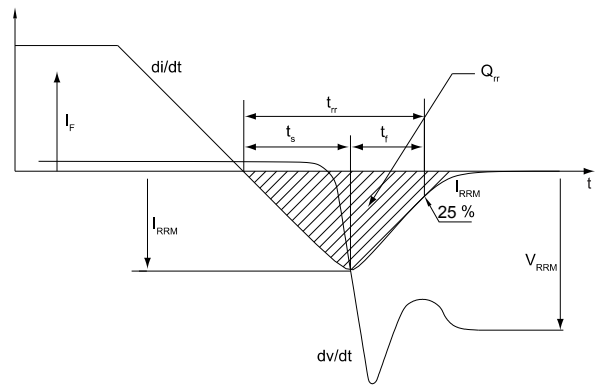
AM01504v1

Figure 28. Gate charge test circuit

AM01505v1

Figure 29. Switching waveform

AM01506v1

Figure 30. Diode reverse recovery waveform

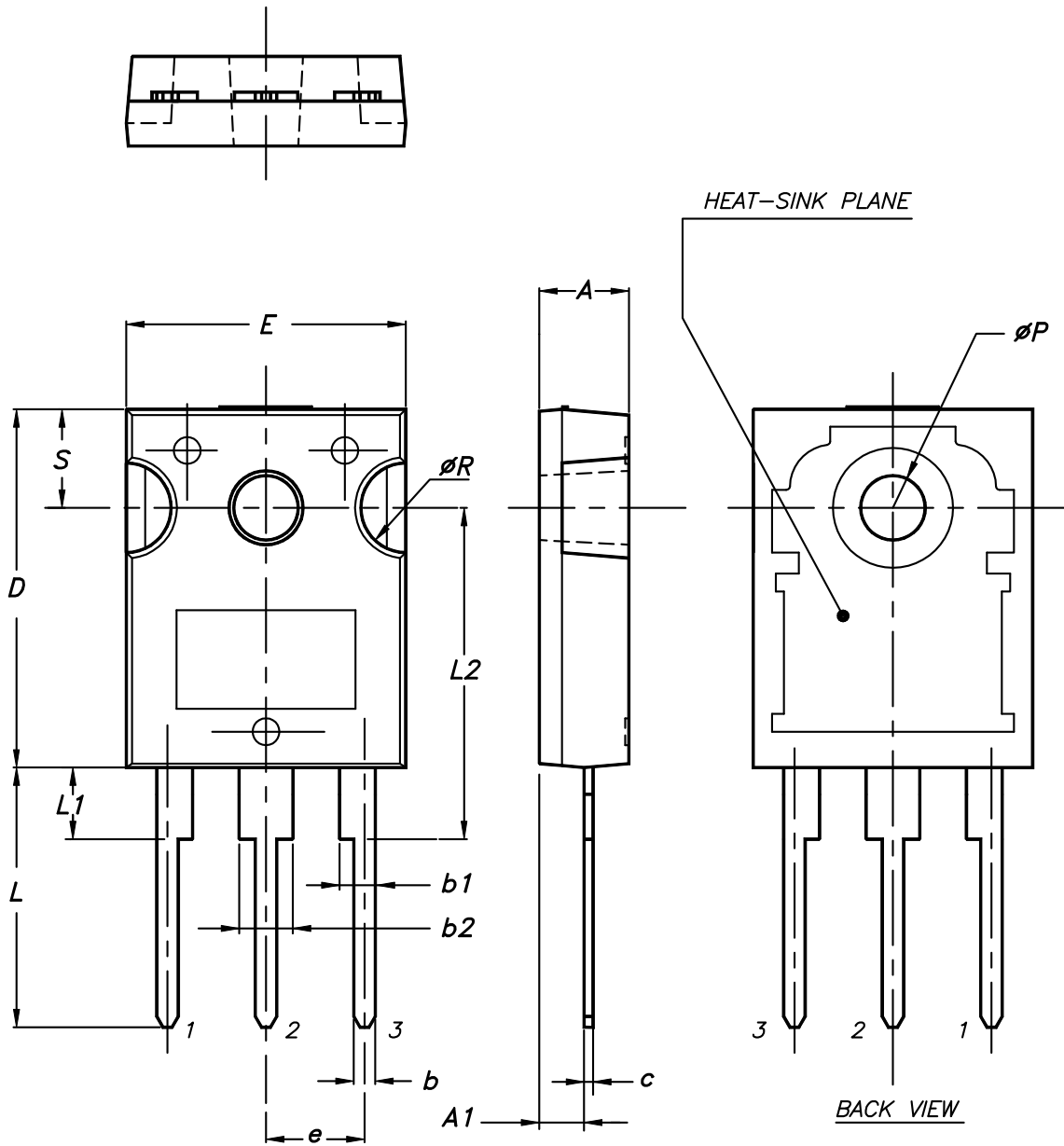
AM01507v1

4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of **ECOPACK** packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

4.1 TO-247 package information

Figure 31. TO-247 package outline



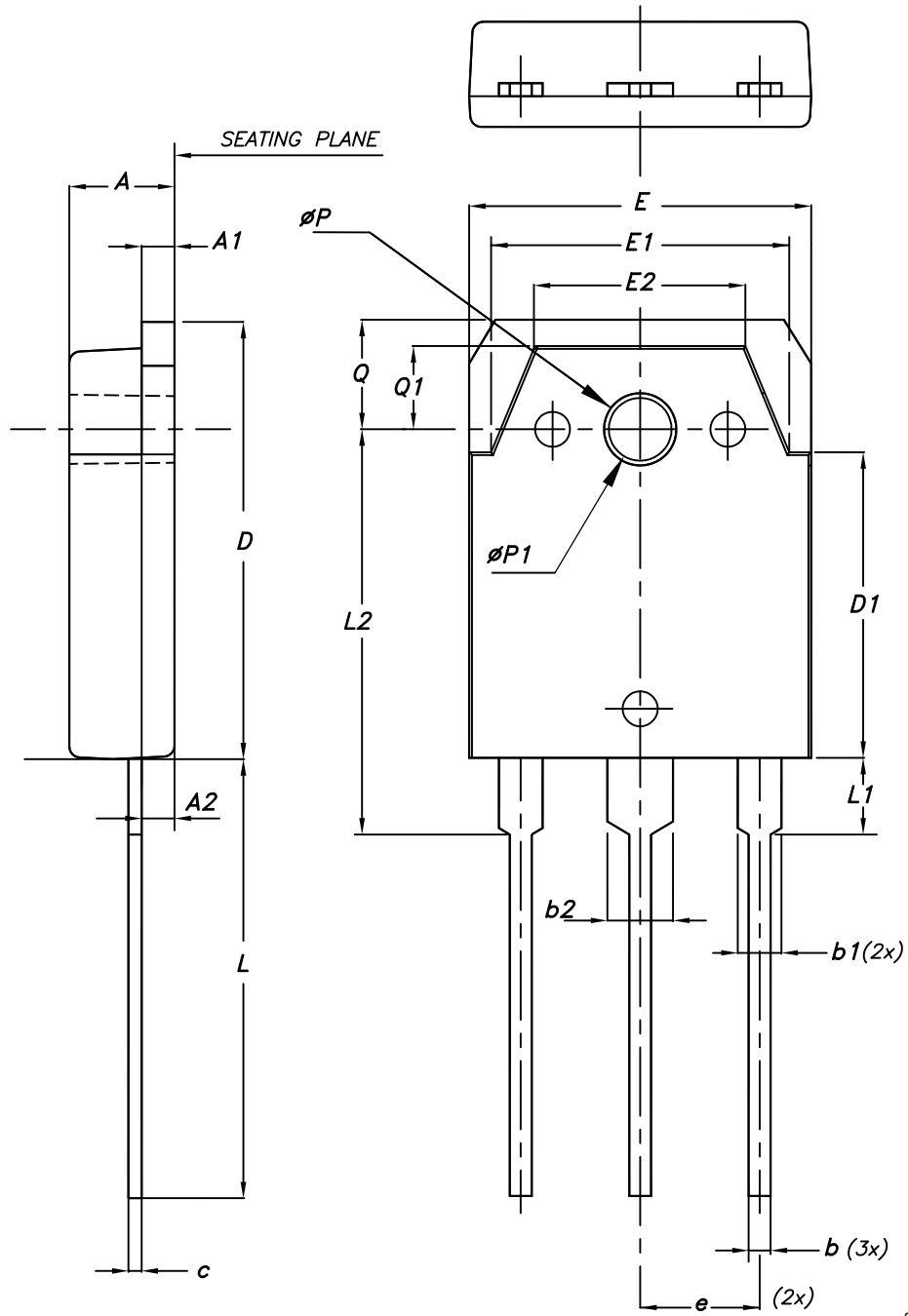
0075325_9

Table 7. TO-247 package mechanical data

| Dim. | mm | | |
|------|-------|-------|-------|
| | Min. | Typ. | Max. |
| A | 4.85 | | 5.15 |
| A1 | 2.20 | | 2.60 |
| b | 1.0 | | 1.40 |
| b1 | 2.0 | | 2.40 |
| b2 | 3.0 | | 3.40 |
| c | 0.40 | | 0.80 |
| D | 19.85 | | 20.15 |
| E | 15.45 | | 15.75 |
| e | 5.30 | 5.45 | 5.60 |
| L | 14.20 | | 14.80 |
| L1 | 3.70 | | 4.30 |
| L2 | | 18.50 | |
| ØP | 3.55 | | 3.65 |
| ØR | 4.50 | | 5.50 |
| S | 5.30 | 5.50 | 5.70 |

4.2 TO-3P package information

Figure 32. TO-3P package outline



8045950_3

Table 8. TO-3P package mechanical data

| Dim. | mm | | |
|------|-------|-------|-------|
| | Min. | Typ. | Max. |
| A | 4.60 | 4.80 | 5.00 |
| A1 | 1.45 | 1.50 | 1.65 |
| A2 | 1.20 | 1.40 | 1.60 |
| b | 0.80 | 1.00 | 1.20 |
| b1 | 1.80 | 2.00 | 2.20 |
| b2 | 2.80 | 3.00 | 3.20 |
| c | 0.55 | 0.60 | 0.75 |
| D | 19.70 | 19.90 | 20.10 |
| D1 | 13.70 | 13.90 | 14.10 |
| E | 15.40 | 15.60 | 15.80 |
| E1 | 13.40 | 13.60 | 13.80 |
| E2 | 9.40 | 9.60 | 9.90 |
| e | 5.15 | 5.45 | 5.75 |
| L | 19.80 | 20.00 | 20.20 |
| L1 | 3.30 | 3.50 | 3.70 |
| L2 | 18.20 | 18.40 | 18.60 |
| ØP | 3.30 | 3.40 | 3.50 |
| ØP1 | 3.10 | 3.20 | 3.30 |
| Q | 4.80 | 5.00 | 5.20 |
| Q1 | 3.60 | 3.80 | 4.00 |

Revision history

Table 9. Document revision history

| Date | Revision | Changes |
|-------------|----------|--|
| 12-Mar-2013 | 1 | First release. |
| 18-Sep-2013 | 2 | Document status promoted from preliminary to production data. Added Section 2.1: <i>Electrical characteristics (curves)</i> |
| 20-Nov-2013 | 3 | Added device in Max247. Modified <i>Table 1</i> accordingly. Updated <i>Section 4: Package information</i> . Minor text changes in cover page. |
| 24-Jan-2014 | 4 | Updated title and description in cover page. Updated <i>Table 6: IGBT switching characteristics (inductive load)</i> , <i>Table 7: Diode switching characteristics (inductive load)</i> , <i>Figure 9: Forward bias safe operating area</i> and <i>Figure 14: Switching energy vs. temperature</i> . |
| 13-Jun-2014 | 5 | Updated <i>Figure 5: Collector current vs. case temperature</i> , <i>Figure 6: Power dissipation vs. case temperature</i> , <i>Figure 18: Switching times vs. collector current</i> , <i>Figure 19: Switching times vs. gate resistance</i> and <i>Figure 24: Capacitance variations</i> . Added <i>Figure 25: Collector current vs. switching frequency</i> . Updated <i>Section 4: Package information</i> . Minor text changes. |
| 07-May-2015 | 6 | Added TO-247 long leads package information. |
| 21-Sep-2016 | 7 | Updated <i>Figure 2: "Output characteristics (T_J= 25 °C)"</i> , <i>Figure 3: "Output characteristics (T_J= 175 °C)"</i> , <i>Figure 4: "Transfer characteristics"</i> , <i>Figure 7: "VCE(sat) vs. junction temperature"</i> and <i>Figure 8: "VCE (sat) vs. collector current"</i> . The part number STGY80H65DFB has been moved to a separate datasheet. Minor text changes. |
| 17-Nov-2016 | 8 | Updated <i>Table 2: "Absolute maximum ratings"</i> and <i>Figure 9: "Forward bias safe operating area"</i> . The part number STGWA80H65DFB has been moved to a separate datasheet. Updated document accordingly. |
| 14-Jun-2019 | 9 | Modified Table 1. Absolute maximum ratings . Updated Section 4.1 TO-247 package information . Minor text changes. |

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